

## CORRECTION

[View Article Online](#)  
[View Journal](#) | [View Issue](#)

Cite this: *RSC Adv.*, 2025, 15, 22179

DOI: 10.1039/d5ra90083b

[rsc.li/rsc-advances](https://rsc.li/rsc-advances)

# Correction: Structural, electrical, and optical properties of NiO films for surface-enhanced Raman spectroscopy applications

Long Nguyen Hoang,<sup>ab</sup> Le Huu Bao<sup>ab</sup> and Tran Le<sup>\*ab</sup>

Correction for 'Structural, electrical, and optical properties of NiO films for surface-enhanced Raman spectroscopy applications' by Long Nguyen Hoang *et al.*, *RSC Adv.*, 2025, 15, 17365–17376, <https://doi.org/10.1039/D5RA02866C>.

The authors regret that the affiliations were incorrectly shown in the original manuscript. The corrected list of affiliations is as shown herein.

The Royal Society of Chemistry apologises for these errors and any consequent inconvenience to authors and readers.

<sup>a</sup>Faculty of Physics & Engineering Physics, University of Science, VNU-HCM, Ho Chi Minh City, Vietnam. E-mail: [ltran@hcmus.edu.vn](mailto:ltran@hcmus.edu.vn)

<sup>b</sup>Vietnam National University Ho Chi Minh City, Ho Chi Minh City, Vietnam

